Power MOSFET

30 V, 50 A, Single N-Channel, μ8FL

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC-DC Converters
- High Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Paran	Symbol	Value	Unit		
Drain-to-Source Voltage	V_{DSS}	30	V		
Gate-to-Source Voltage	V_{GS}	±20	V		
Continuous Drain		T _A = 25°C	I _D	12.6	Α
Current R _{θJA} (Note 1)		T _A = 85°C	1	9.1	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.1	W
Continuous Drain		T _A = 25°C	I _D	17.5	Α
Current R _{θJA} ≤ 10 s (Note 1)		T _A = 85°C		12.6	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	4.0	W
Continuous Drain	State	T _C = 25°C	I _D	7.1	Α
Current R _{θJA} (Note 2)		T _C = 85°C		5.1	
Power Dissipation R _{θJA} (Note 2)		T _C = 25°C	P _D	0.66	W
Continuous Drain		T _C = 25°C	Ι _D	50	Α
Current R _{θJC} (Note 1)		T _C = 85°C		36	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C		32.9	W
Pulsed Drain Current	$T_A = 25^{\circ}$	C, t _p = 10 μs	I_{DM}	150	Α
Operating Junction and S	T _J , T _{stg}	-55 to +150	°C		
Source Current (Body Did	I _S	33	Α		
Drain to Source dV/dt	dV/dt	6	V/ns		
Single Pulse Drain-to-So $(T_J = 25^{\circ}C, V_{DD} = 50 \text{ V}, \text{V}_{L} = 25 \text{ A}_{pk}, L = 0.1 \text{ mH, F}$	E _{AS}	31	mJ		
Lead Temperature for So (1/8" from case for 10 s)	TL	260	°C		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

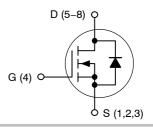


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	(BR)DSS R _{DS(on)} MAX	
30 V	10.5 mΩ @ 10 V	50 A
	17.5 mΩ @ 4.5 V	30 A

N-Channel MOSFET

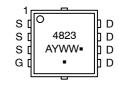




FLAT LEAD

В

MARKING DIAGRAM



4823 = Specific Device Code A = Assembly Location

Y = Year
WW = Work Week
Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4823NTAG	WDFN8 (Pb-Free)	1500/Tape & Reel
NTTFS4823NTWG	WDFN8 (Pb-Free)	5000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	3.8	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	59.4	
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	190.2	
Junction-to-Ambient – (t \leq 10 s) (Note 3)	$R_{ heta JA}$	31.1	

ELECTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•		•		-	-	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				25		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	$T_J = 25^{\circ}C$ $T_J = 125^{\circ}C$			1.0 10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	±20 V			±100	nA
ON CHARACTERISTICS (Note 5)	l		<u>l</u>		ı		L
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2$	250 μΑ	1.5	1.9	2.5	٧
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	I _D = 20 A			8.1	10.5	mΩ
	V _{GS} = 1	V _{GS} = 10 V to 11.5 V	I _D = 10 A		8.0		
		I _D = 20 A			13.5	17.5	
		V _{GS} = 4.5 V	I _D = 10 A		13		
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 20 A			34		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 12 V			750	1013	pF
Output Capacitance	C _{oss}				175	237	
Reverse Transfer Capacitance	C _{rss}				100	150	
Total Gate Charge	Q _{G(TOT)}				6.5	9.0	nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 15	\/		0.8		
Gate-to-Source Charge	Q_{GS}	V _{GS} = 4.5 V, V _{DS} = 15	v, ID = 20 A		2.5		
Gate-to-Drain Charge	Q_{GD}				2.9		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 11.5 V, V _{DS} = 15 V, I _D = 20 A			15		nC
SWITCHING CHARACTERISTICS (N	ote 6)						
Turn-On Delay Time	t _{d(on)}				12		ns
Rise Time	t _r	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			22		
Turn-Off Delay Time	t _{d(off)}				14		
Fall Time	t _f				4		

^{5.} Pulse Test: pulse width = 300 μ s, duty cycle \leq 2%.

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

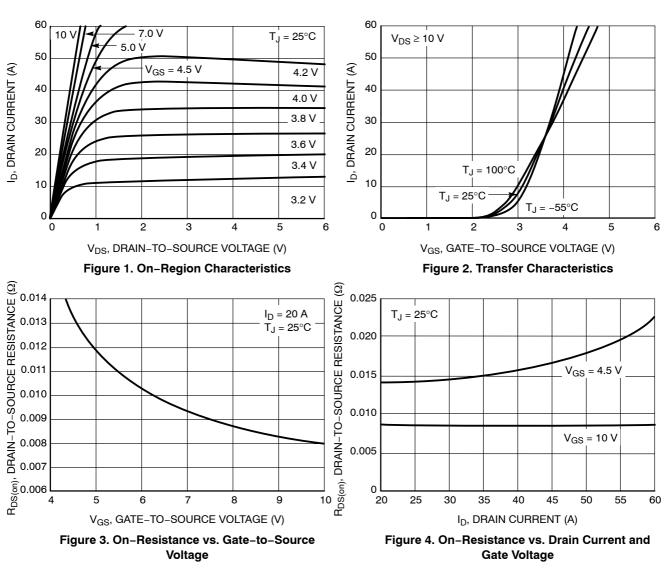
^{6.} Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTIC	S (Note 6)		•			•	
Turn-On Delay Time	t _{d(on)}	V _{GS} = 11.5 V, V _{DS} = 15 V,			7.0		ns
Rise Time	t _r				18		1
Turn-Off Delay Time	t _{d(off)}	$I_D = 15 \text{ A}, R_G =$			20		1
Fall Time	t _f				2.0		1
DRAIN-SOURCE DIODE CHARA	ACTERISTICS		•				
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V},$ $T_J = 25^{\circ}\text{C}$		0.93	1.1	V	
		T _J = 125°C		0.83		1	
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V},$ $d_{1S}/d_t = 100 \text{ A/}\mu\text{s},$ $I_S = 20 \text{ A}$			13		ns
Charge Time	ta				7.5		1
Discharge Time	t _b				5.5		1
Reverse Recovery Charge	Q _{RR}				4.0		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				0.38		nΗ
Drain Inductance	L _D	T _A = 25°C			0.054		1
Gate Inductance	L _G				1.3		1
Gate Resistance	R_{G}				0.65	2.0	Ω

^{5.} Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



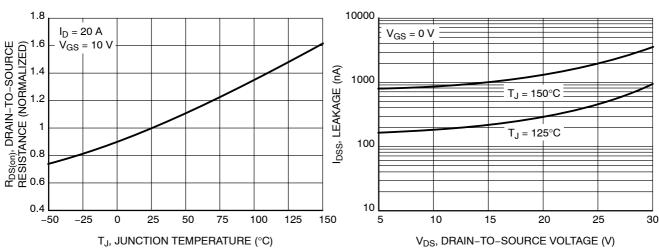


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

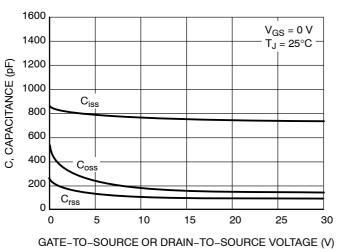


Figure 7. Capacitance Variation

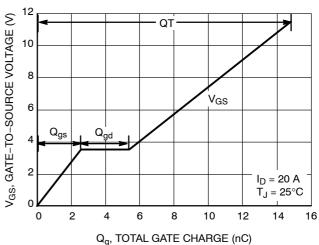


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

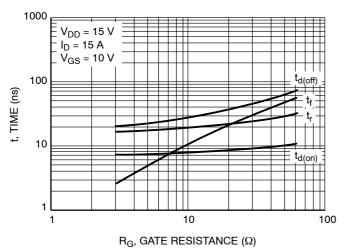


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

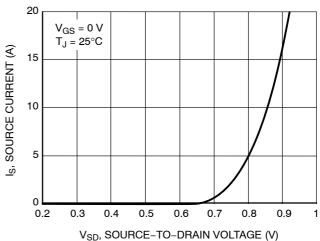


Figure 10. Diode Forward Voltage vs. Current

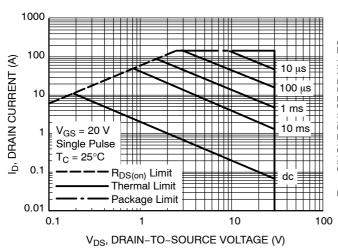


Figure 11. Maximum Rated Forward Biased Safe Operating Area

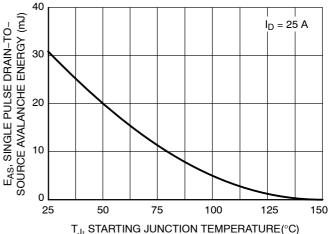


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature



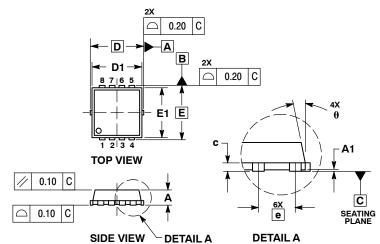




SCALE 2:1

WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC	
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е		0.65 BSC			0.026 BS0)
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

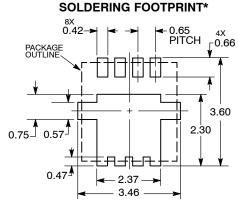


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code Α = Assembly Location

= Year = Work Week WW = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1	

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^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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